



03N50-CB

Preliminary

Power MOSFET

0.3A, 500V N-CHANNEL POWER MOSFET

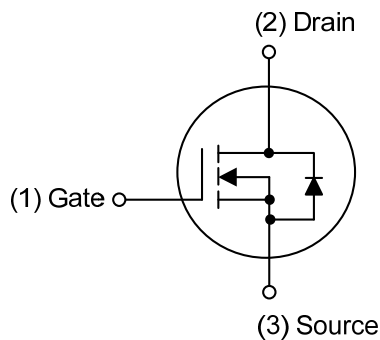
DESCRIPTION

The UTC **03N50-CB** is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient AC to DC converters and bridge circuits.

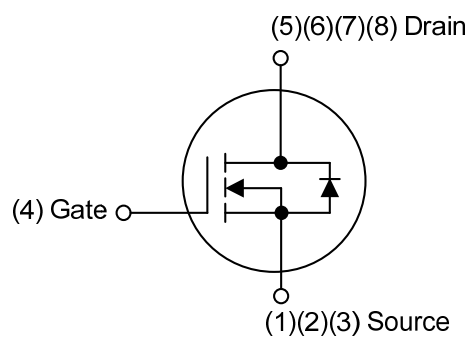
FEATURES

- * $R_{DS(ON)} \leq 24 \Omega$ @ $V_{GS}=10V$, $I_D=0.15A$
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

SYMBOL



SOT-223



SOP-8

ORDERING INFORMATION

Ordering Number		Package	Pin Assignment								Packing
Lead Free	Halogen Free		1	2	3	4	5	6	7	8	
03N50L-AA3-R	03N50G-AA3-R	SOT-223	G	D	S	-	-	-	-	-	Tape Reel
03N50L-S08-R	03N50G-S08-R	SOP-8	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

	(1) Packing Type	(1) R: Tape Reel
	(2) Package Type	(2) AA3: SOT-223, S08: SOP-8
	(3) Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

MARKING

SOT-223	SOP-8
<div><div>03N50</div><div><div></div><div></div><div></div><div></div><div></div></div><div>1</div></div> <div>Lot Code</div> <div>L: Lead Free G: Halogen Free Date Code</div>	<div><div>8765</div><div>UTC</div><div>03N50</div><div><div></div><div></div><div></div><div></div></div><div>1234</div></div> <div>Date Code L: Lead Free G: Halogen Free Lot Code</div>

■ ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	500	V
Gate-Source Voltage		V_{GSS}	± 30	V
Drain Current	Continuous	I_D	0.3	A
	Pulsed (Note 2)	I_{DM}	0.6	A
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.2	V/ns
Power Dissipation	SOT-223	P_D	0.8	W
	SOP-8		1.2	W
Junction Temperature		T_J	+150	$^\circ\text{C}$
Storage Temperature		T_{STG}	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. $I_{SD} \leq 0.3\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction-to-Ambient	SOT-223	θ_{JA}	160	$^\circ\text{C}/\text{W}$
	SOP-8		125	$^\circ\text{C}/\text{W}$
Junction-to-Case	SOT-223	θ_{JC}	156	$^\circ\text{C}/\text{W}$
	SOP-8		104	$^\circ\text{C}/\text{W}$

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

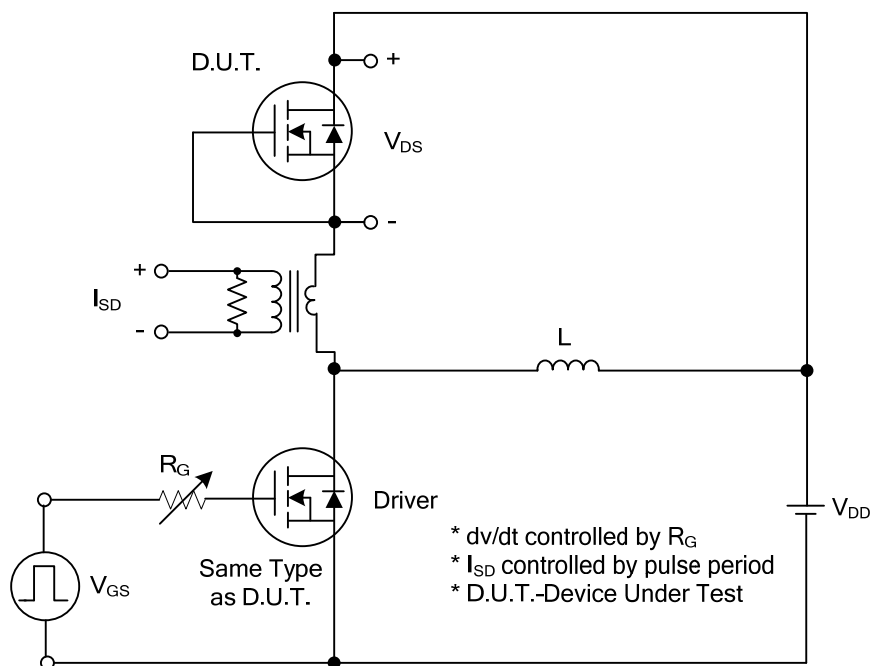
■ ELECTRICAL CHARACTERISTICS ($T_J=25^{\circ}\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D =250μA	500			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =500V, V _{GS} =0V			10	μA
Gate-Source Leakage Current	Forward	I _{GSS}	V _{GS} =30V, V _{DS} =0V			100	nA
	Reverse		V _{GS} =-30V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250μA	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =0.15A			24	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C _{ISS}	V _{DS} =25V, V _{GS} =0V, f=1MHz		36		pF
Output Capacitance		C _{OSS}			10.5		pF
Reverse Transfer Capacitance		C _{RSS}			2.2		pF
SWITCHING CHARACTERISTICS							
Total Gate Charge (Note 1)		Q _G	V _{DS} =400V, V _{GS} =10V, I _D =0.3A, (Note 1, 2)		8.5		nC
Gate to Source Charge		Q _{GS}			2		nC
Gate to Drain Charge		Q _{GD}			0.8		nC
Turn-ON Delay Time (Note 1)		t _{D(ON)}	V _{DD} =100V, V _{GS} =10V, I _D =0.3A, R _G =25Ω (Note 1, 2)		3.2		ns
Rise Time		t _R			17		ns
Turn-OFF Delay Time		t _{D(OFF)}			20		ns
Fall-Time		t _F			86		ns
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS							
Maximum Body-Diode Continuous Current		I _S				0.3	A
Maximum Body-Diode Pulsed Current (Note 1)		I _{SM}				0.6	A
Drain-Source Diode Forward Voltage (Note 1)		V _{SD}	I _S =0.3A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time		t _{rr}	I _S =0.3A, V _{GS} =0V		130		ns
Body Diode Reverse Recovery Charge		Q _{rr}	dI _F /dt=100A/μs		92		nC

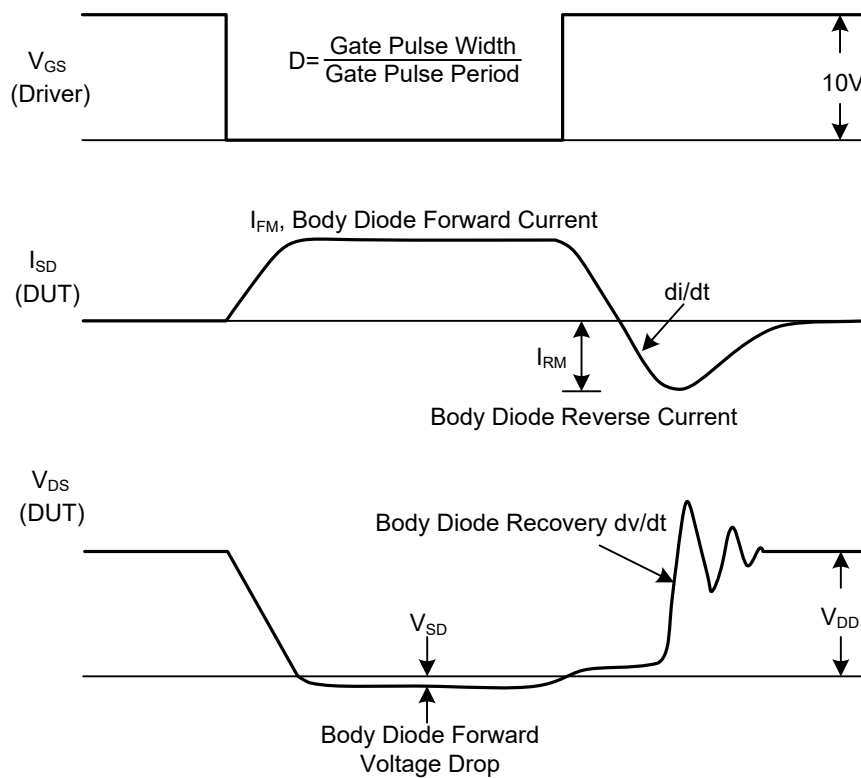
Notes: 1. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

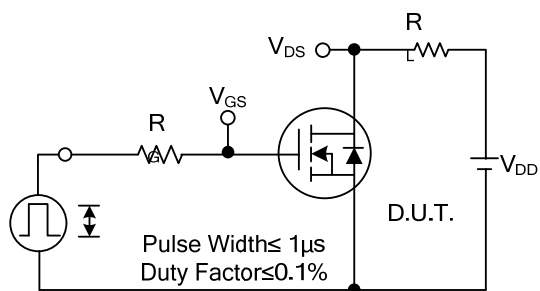


Peak Diode Recovery dv/dt Test Circuit

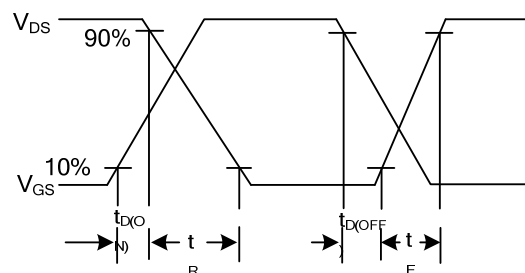


Peak Diode Recovery dv/dt Waveforms

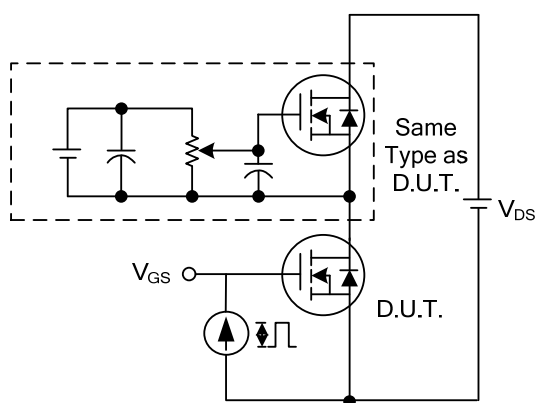
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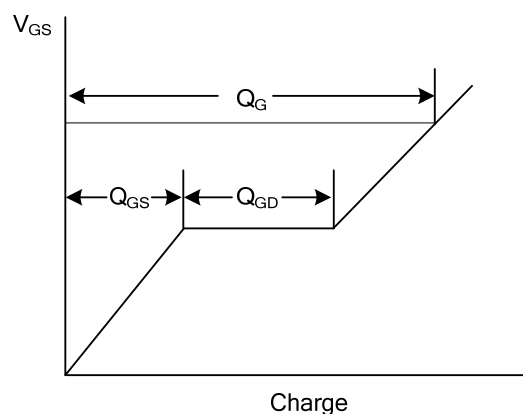
Switching Test Circuit



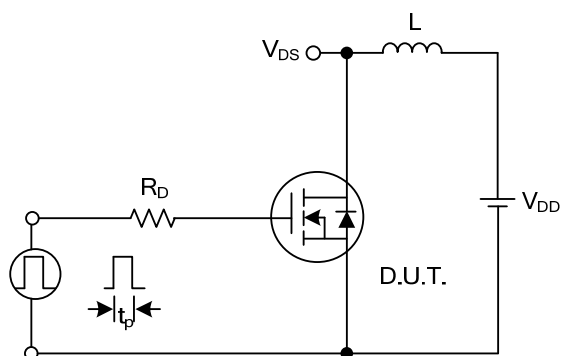
Switching Waveforms



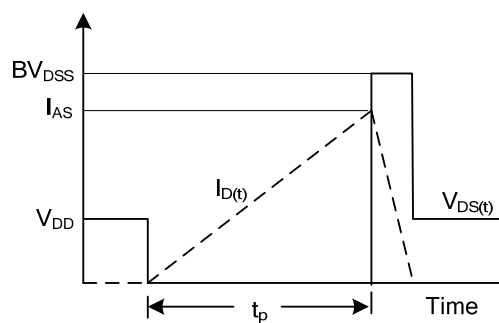
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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